

Features

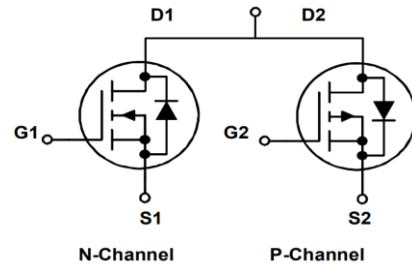
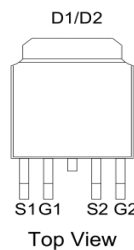
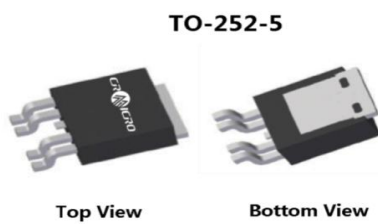
- Uses CRM(CQ) advanced Trench technology
- Extremely low on-resistance $R_{DS(on)}$
- Excellent $Q_g \times R_{DS(on)}$ product(FOM)
- Complementary N-ch and P-ch MOSFET

Product Summary

Symbol	N-Ch	P-Ch
V_{DS}	60V	-60V
$R_{DS(on)}$ typ.	12m Ω	53m Ω
I_D	16A	-16A

Applications

- Motor drive

100% DVDS Tested
100% Avalanche Tested

Package Marking and Ordering Information

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
CRMM6905C	CRMM6905C	TO-252-5	Taping	N/A	N/A	2500pcs

Absolute Maximum Ratings

Parameter	Symbol	Maximum		Unit
		N-Ch	P-Ch	
Drain-source voltage	V_{DS}	60	-60	V
Continuous drain current $T_C = 25^\circ\text{C}$ (Silicon limit)	I_D	40	-27	A
Continuous drain current $T_C = 25^\circ\text{C}$ (Package limit)	I_D	16	-16	A
Pulsed drain current ($T_C = 25^\circ\text{C}$, t_p limited by T_{jmax})	$I_{D \text{ pulse}}$	64	-64	A
Avalanche energy, single pulse ($L=0.5\text{mH}$, $R_g=25\Omega$)	E_{AS}	156	72	mJ
Gate-Source voltage	V_{GS}	± 20	± 20	V
Power dissipation ($T_C = 25^\circ\text{C}$)	P_{tot}	38.8	38.8	W
Operating junction and storage temperature	T_j, T_{stg}	-55...+150		$^\circ\text{C}$

Thermal Resistance

Parameter	Symbol	Typ	Max	Unit
Thermal resistance, junction – case.	R_{thJC}	2.3	3.2	$^\circ\text{C/W}$
Thermal resistance, junction – ambient(min.footprint)	R_{thJA}	79.0	94.8	$^\circ\text{C/W}$

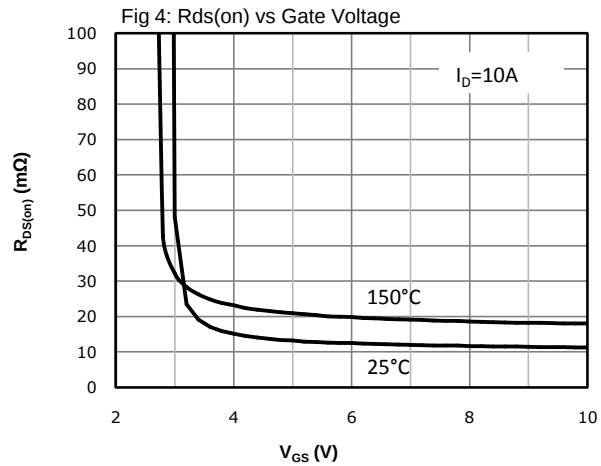
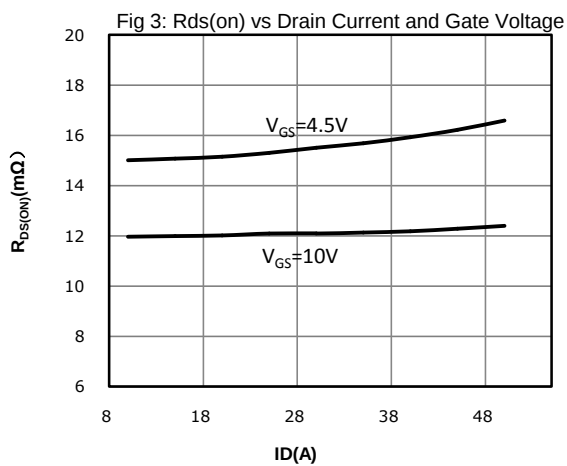
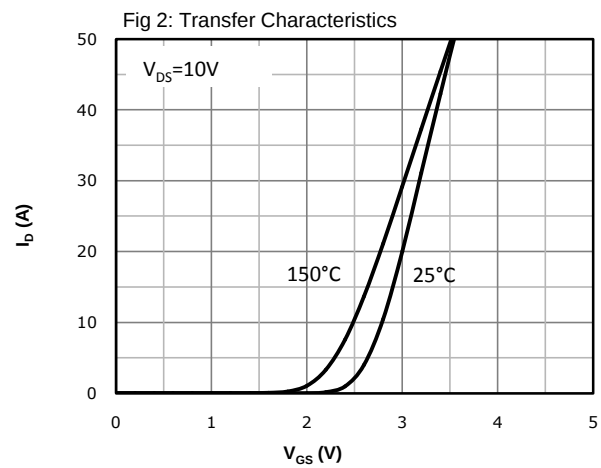
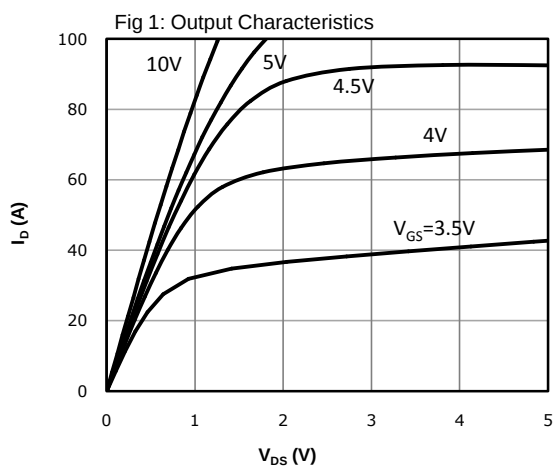
N-Channel Electrical Characteristic (at $T_j = 25^\circ\text{C}$, unless otherwise specified)

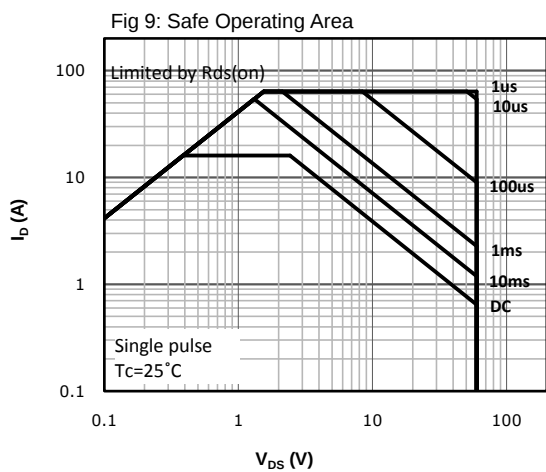
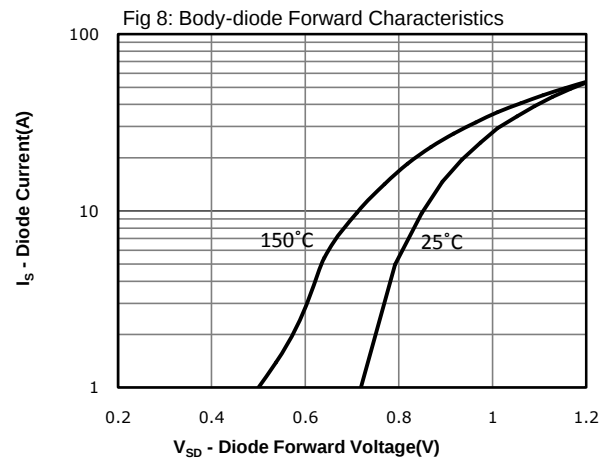
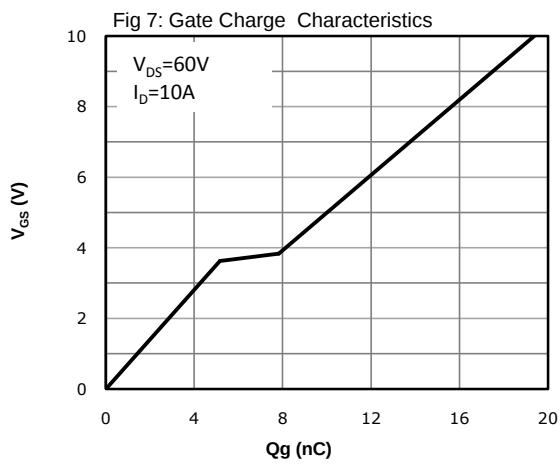
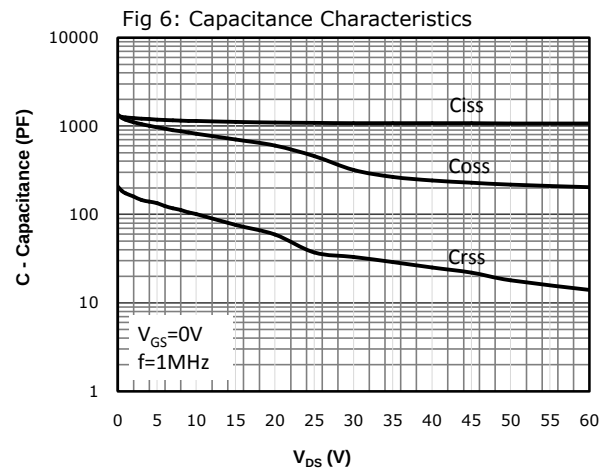
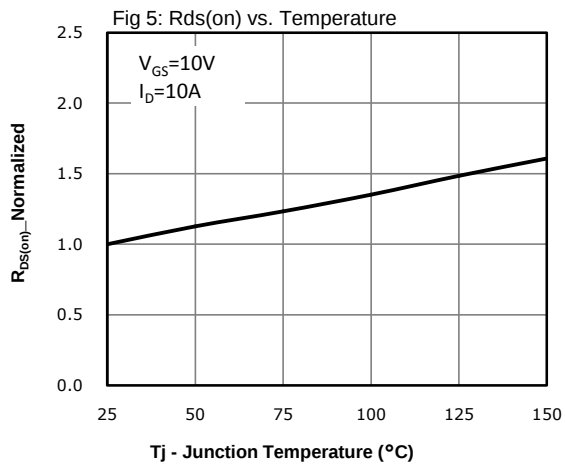
Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Static Characteristic						
Drain-source breakdown voltage	BV _{DSS}	60	-	-	V	V _{GS} =0V, I _D =250uA
Gate threshold voltage	V _{GS(th)}	1.3	1.8	2.2	V	V _{DS} =V _{GS} , I _D =250uA
Zero gate voltage drain current	I _{DSS}	-	0.08	1	μA	V _{DS} =60V, V _{GS} =0V T _j =25°C T _j =125°C
Gate-source leakage current	I _{GSS}	-	±10	±100	nA	V _{GS} =±20V, V _{DS} =0V
Drain-source on-state resistance	R _{DS(on)}	-	15.0	18.0	mΩ	V _{GS} =4.5V, I _D =10A
		-	12.0	15.0		V _{GS} =10V, I _D =10A
Transconductance	g _{fs}	-	39.4	-	S	V _{DS} =10V, I _D =10A
Dynamic Characteristic						
Input Capacitance	C _{iss}	-	1080	-	pF	V _{GS} =0V, V _{DS} =60V, f=1MHz
Output Capacitance	C _{oss}	-	204	-		
Reverse Transfer Capacitance	C _{rss}	-	16	-		
Gate Total Charge	Q _G	-	19.5	-	nC	V _{GS} =10V, V _{DS} =60V, I _D =10A, f=1MHz
Gate-Source charge	Q _{gs}	-	4.9	-		
Gate-Drain charge	Q _{gd}	-	3.1	-		
Turn-on delay time	t _{d(on)}	-	8.0	-	ns	V _{GS} =10V, V _{DD} =30V, R _{G_ext} =2.7Ω, ID=10A
Rise time	t _r	-	22.7	-		
Turn-off delay time	t _{d(off)}	-	19.7	-		
Fall time	t _f	-	25.3	-		
Gate resistance	R _G	-	1.5	-	Ω	V _{GS} =0V, V _{DS} =0V, f=1MHz

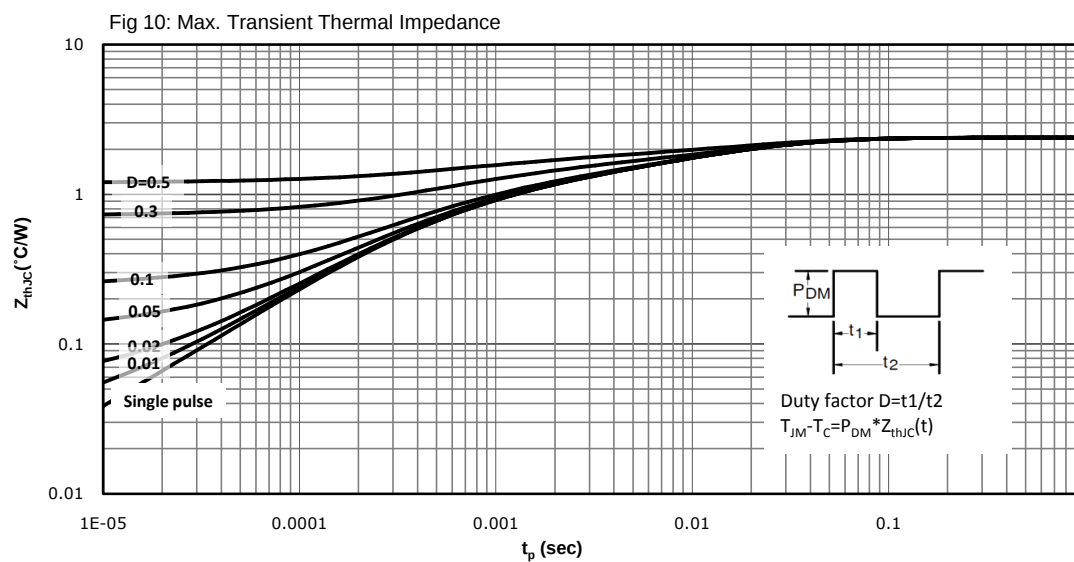
Body Diode Characteristic

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Body Diode Forward Voltage	V_{SD}	-	0.85	1.20	V	$V_{GS}=0V, I_{SD}=10A$
Body Diode Reverse Recovery Time	t_{rr}	-	28.1	-	ns	$I_F=10A, dI/dt=100A/\mu s$
Body Diode Reverse Recovery Charge	Q_{rr}	-	15.6	-	nC	

N-Channel Typical Performance Characteristics





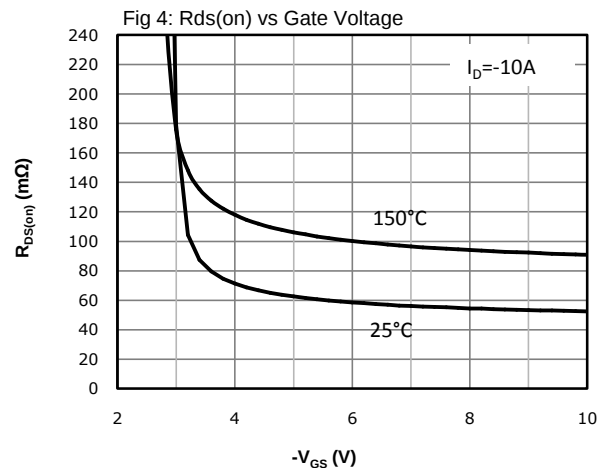
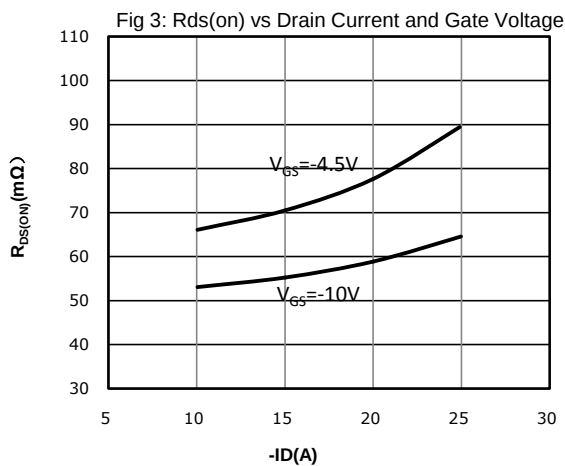
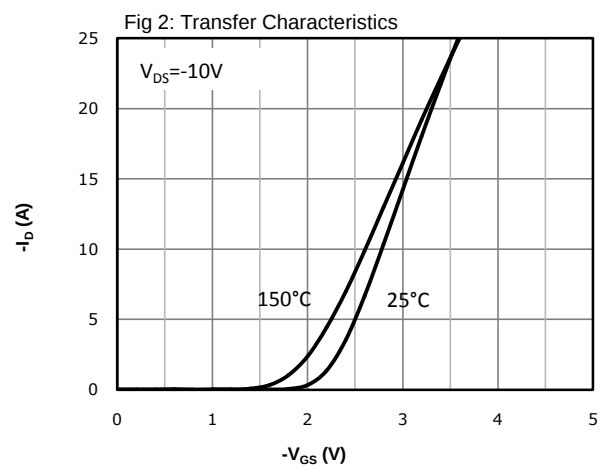
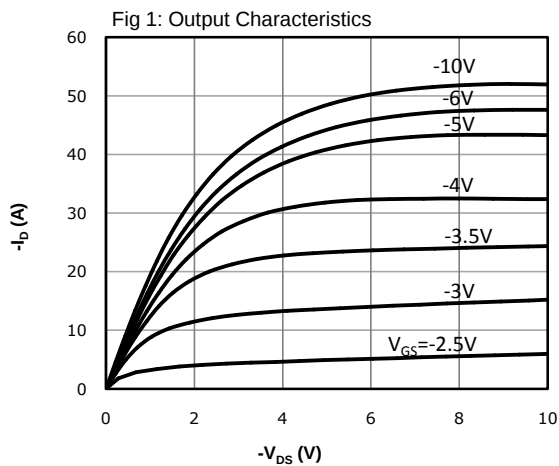


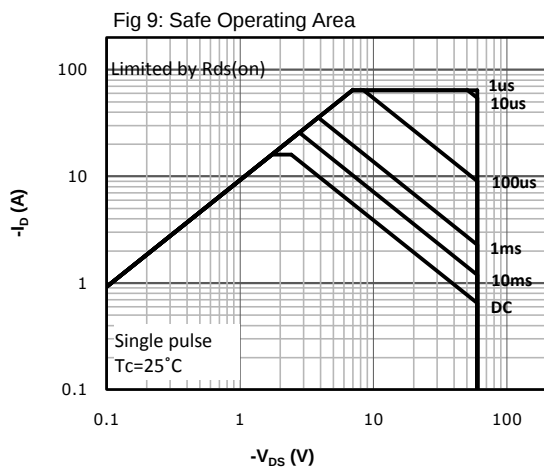
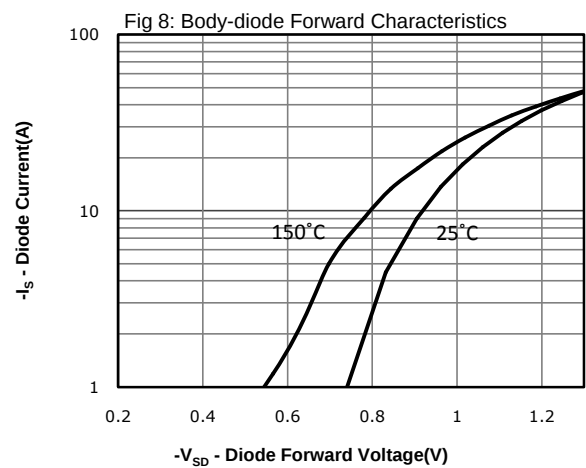
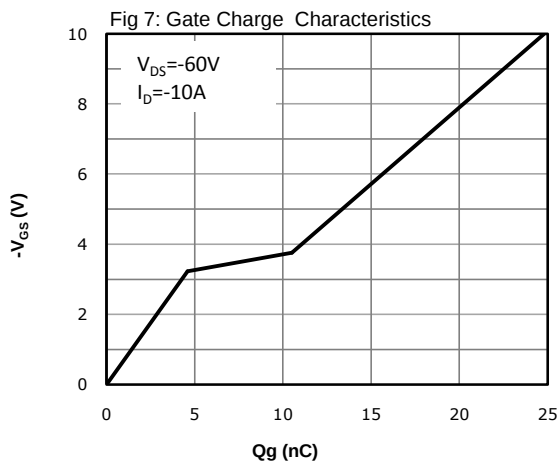
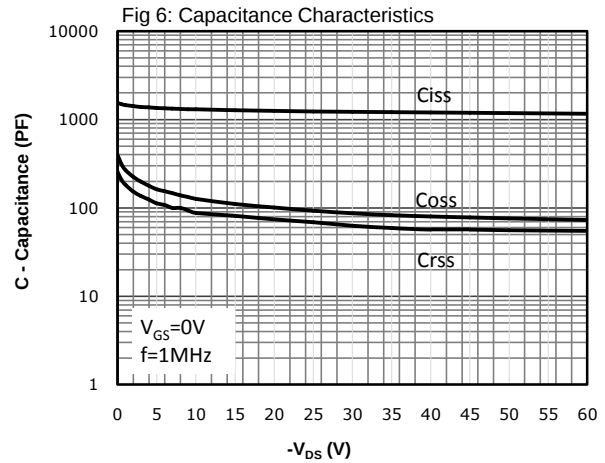
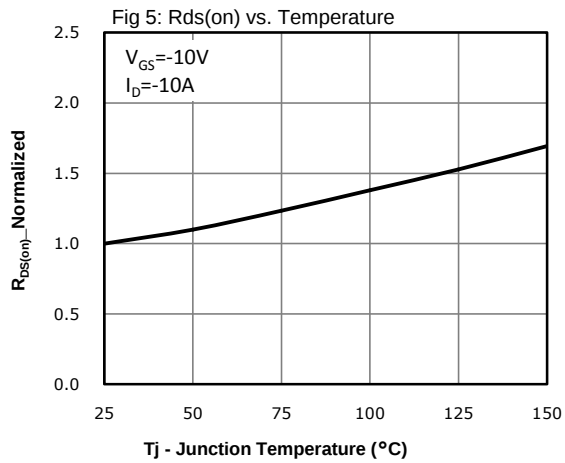
P-Channel Electrical Characteristic (at $T_j = 25^\circ\text{C}$, unless otherwise specified)

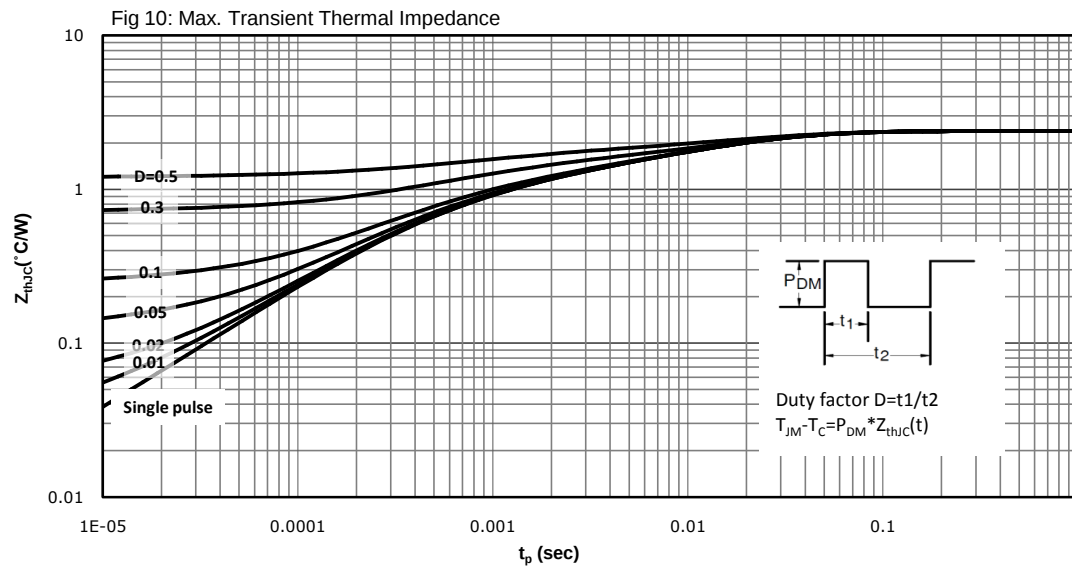
Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Static Characteristic						
Drain-source breakdown voltage	BV _{DSS}	-60	-	-	V	V _{GS} =0V, I _D =-250uA
Gate threshold voltage	V _{GS(th)}	-1	-1.4	-2	V	V _{DS} =V _{GS} , I _D =-250uA
Zero gate voltage drain current	I _{DSS}	-	-0.08	-1	μA	V _{DS} =-60V, V _{GS} =0V T _j =25°C T _j =125°C
Gate-source leakage current	I _{GSS}	-	±10	±100	nA	V _{GS} =±20V, V _{DS} =0V
Drain-source on-state resistance	R _{DS(on)}	-	66.0	79.0	mΩ	V _{GS} =-4.5V, I _D =-10A
		-	53.0	64.0		V _{GS} =-10V, I _D =-10A
Transconductance	g _{fs}	-	18.3	-	S	V _{DS} =-10V, I _D =-10A
Dynamic Characteristic						
Input Capacitance	C _{iss}	-	1168	-	pF	V _{GS} =0V, V _{DS} =-60V, f=1MHz
Output Capacitance	C _{oss}	-	73	-		
Reverse Transfer Capacitance	C _{rss}	-	56	-		
Gate Total Charge	Q _G	-	25.5	-	nC	V _{GS} =-10V, V _{DS} =-60V, I _D =-10A, f=1MHz
Gate-Source charge	Q _{gs}	-	4.7	-		
Gate-Drain charge	Q _{gd}	-	6.0	-		
Turn-on delay time	t _{d(on)}	-	7.2	-	ns	V _{GS} =-10V, V _{DD} =-30V, R _{G_ext} =2.7Ω, ID=-10A
Rise time	t _r	-	28.0	-		
Turn-off delay time	t _{d(off)}	-	46.1	-		
Fall time	t _f	-	68.5	-		
Gate resistance	R _G	-	12.1	-	Ω	V _{GS} =0V, V _{DS} =0V, f=1MHz

Body Diode Characteristic

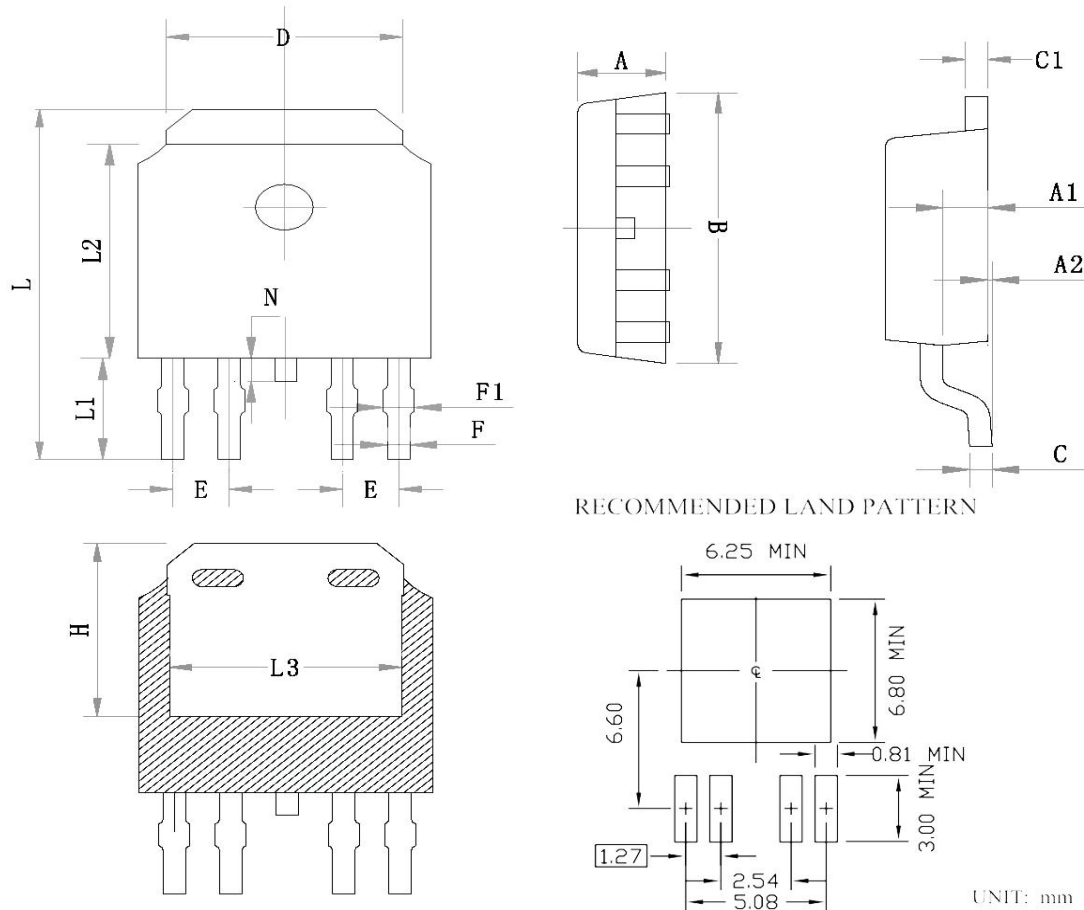
Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Body Diode Forward Voltage	V_{SD}	-	-0.92	-1.20	V	$V_{GS}=0V$, $I_{SD}=-10A$
Body Diode Reverse Recovery Time	t_{rr}	-	21.7	-	ns	$I_F=10A$, $dI/dt=100A/\mu s$
Body Diode Reverse Recovery Charge	Q_{rr}	-	15.4	-	nC	

P-Channel Typical Performance Characteristics






Package Outline: TO-252-5



SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES		
	MIN	NOM	MAX	MIN	NOM	MAX
A	2.20	2.30	2.40	0.087	0.091	0.094
A1	0.91	1.01	1.11	0.036	0.040	0.044
A2	0.00	----	0.25	0.000	----	0.010
B	6.40	6.60	6.80	0.252	0.260	0.268
C	0.45	0.50	0.58	0.018	0.020	0.023
C1	0.45	0.50	0.58	0.018	0.020	0.023
D	5.12	5.32	5.52	0.202	0.209	0.217
E	1.27 BSC			0.050 BSC		
F	0.40	0.50	0.60	0.016	0.020	0.024
F1	0.45	0.65	0.80	0.018	0.026	0.031
H	4.57	4.85	5.10	0.180	0.191	0.201
L	9.40	9.90	10.20	0.370	0.390	0.402
L1	2.40	2.75	3.00	0.094	0.108	0.118
L2	5.40	5.80	6.25	0.213	0.228	0.246
L3	5.00	5.30	5.50	0.197	0.209	0.217
N	0.45	----	1.20	0.018	----	0.047

NOTE

1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.
MOLD FLASH SHOULD BE LESS THAN 6MIL
2. DIMENSION L IS MEASURED IN GAUGE PLANE.
3. TOLERANCE 0.10mm UNLESS OTHER WISE SPECIFIED.
4. CONTROLLING DIMENSION IS MILLIMETER.
CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

Revision History

Revision	Date	Major changes
1.1	2022/12/15	Release of formal version

Disclaimer

Unless otherwise specified in the datasheet, the product is designed and qualified as a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability, such as automotive, aviation/aerospace and life-support devices or systems.

Any and all semiconductor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

This product is suitable for reflow soldering up to 260℃, not very suitable for wave soldering.

The reliability of this product is not guaranteed under specific conditions when accepted by customers.

CRM(CQ) reserves the right to improve product design, function and reliability without notice.